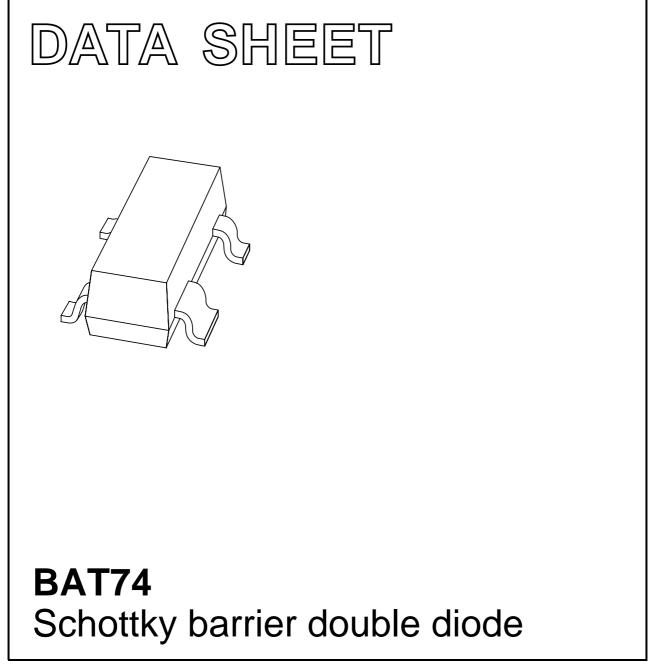
DISCRETE SEMICONDUCTORS



Product data sheet Supersedes data of 1996 Mar 19 2001 Sep 05



FEATURES

- Low forward voltage
- · Guard ring protected
- Small plastic SMD package.

APPLICATIONS

- Ultra high-speed switching
- Voltage clamping
- Protection circuits
- Blocking diodes.

DESCRIPTION

Planar Schottky barrier double diode. Two separate dies encapsulated in a SOT143B small plastic SMD package.

MARKING

TYPE NUMBER	MARKING CODE		
BAT74	L41		

PINNING

PIN	DESCRIPTION
1	cathode (k ₁)
2	cathode (k ₂)
3	anode (a ₂)
4	anode (a ₁)

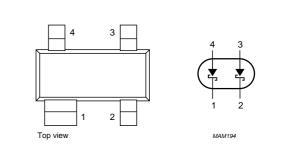


Fig.1 Simplified outline (SOT143B), pin configuration and symbol.

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
Per diode					
V _R	continuous reverse voltage		_	30	V
I _F	continuous forward current		-	200	mA
I _{FRM}	repetitive peak forward current	$t_p \le 1 \text{ s}; \delta \le 0.5$	-	300	mA
I _{FSM}	non-repetitive peak forward current	t _p < 10 ms		600	mA
P _{tot}	total power dissipation	$T_{amb} \le 25 \ ^{\circ}C$; see Fig.2	-	230	mW
T _{stg}	storage temperature		-65	+150	°C
Tj	junction temperature		-	125	°C
T _{amb}	operating ambient temperature		-65	+125	°C
Double die	ode operation				
V _R	continuous reverse voltage		-	30	V
		series connection	-	60	V
I _F	continuous forward current		-	110 ⁽¹⁾	mA
I _{FRM}	repetitive peak forward current	$t_p \le 1 \text{ s}; \delta \le 0.5$	-	200	mA

Note

1. If both diodes are in forward operation at the same moment, total device current is max. 110 mA. If one diode is in reverse operation and the other is in forward operation at the same moment, total device current is max. 200 mA.

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THERMAL CHARACTERISTICS

SYMBOL	PARAMETER CONDITIONS		VALUE	UNIT
R _{th j-a}	thermal resistance from junction to ambient	note 1	500	K/W

Note

1. Refer to SOT143B standard mounting conditions.

ELECTRICAL CHARACTERISTICS

 T_{amb} = 25 °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MAX.	UNIT	
Per diode					
V _F	forward voltage	see Fig.3			
		I _F = 0.1 mA	240	mV	
		I _F = 1 mA; note 1	320	mV	
		I _F = 10 mA	400	mV	
		I _F = 30 mA	500	mV	
		I _F = 100 mA	800	mV	
I _R	reverse current	V _R = 25 V; note 2; see Fig.4	2	μA	
t _{rr}	reverse recovery time	when switched from $I_F = 10$ mA to $I_R = 10$ mA; $R_L = 100 \Omega$; measured at $I_R = 1$ mA; see Fig.6	5	ns	
C _d	diode capacitance	$f = 1 \text{ MHz}; V_R = 1 \text{ V}; \text{ see Fig.5}$	10	pF	

Notes

1. Temperature coefficient of forward voltage -0.6%/K.

2. Pulsed test: $t_p = 300 \mu s$; $\delta = 0.02$.

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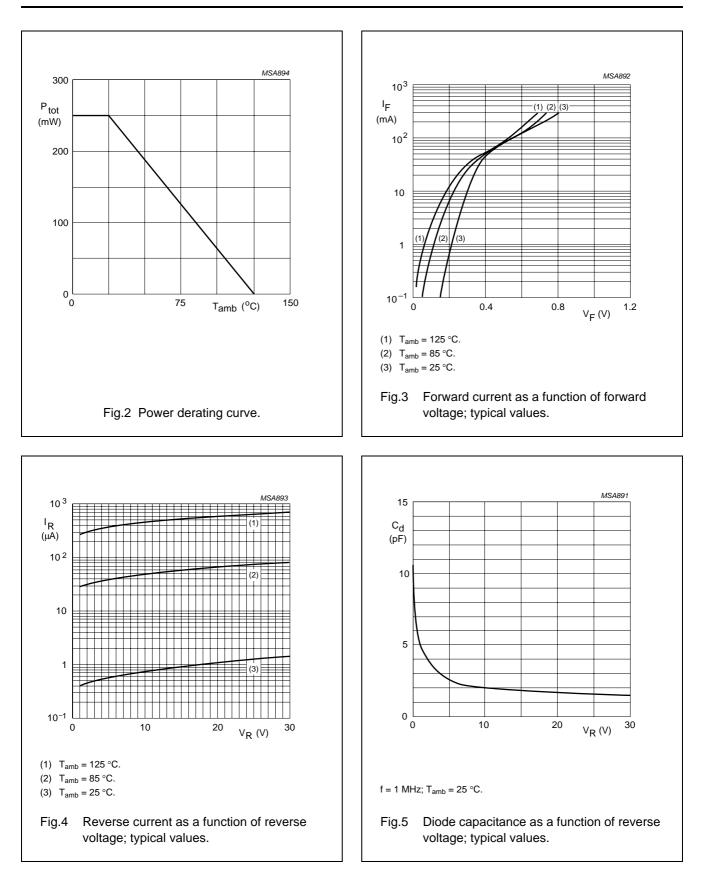
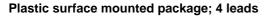
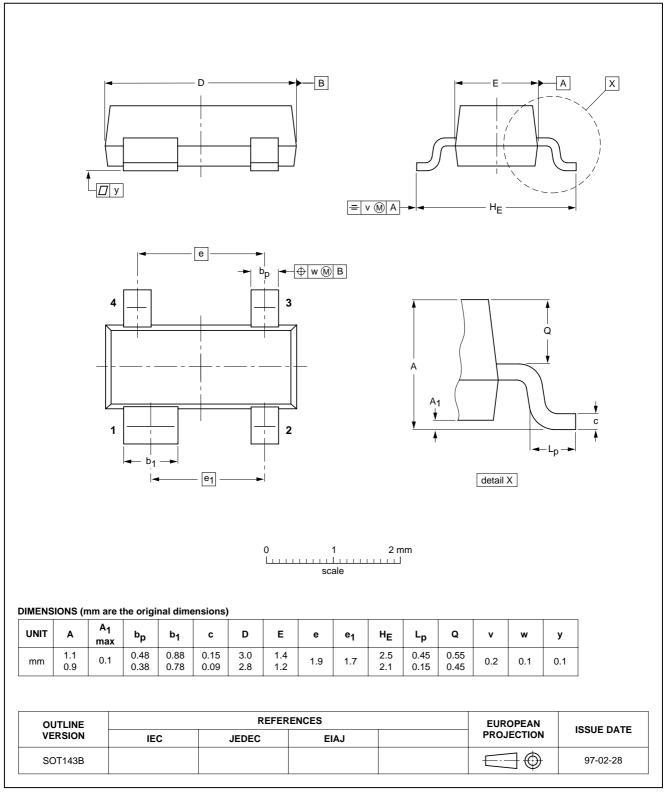


Fig.6 Reverse recovery definitions.

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PACKAGE OUTLINE





SOT143B

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DATA SHEET STATUS

DOCUMENT STATUS ⁽¹⁾	PRODUCT STATUS ⁽²⁾	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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Printed in The Netherlands

613514/02/pp8

Date of release: 2001 Sep 05

Document order number: 9397 750 08588

